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JP6036966A2: THIN FILM CAPACITOR

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Country:

JP Japan

Kind:

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Abstract:

Purpose: To obtain a thin film capacitor capable of further improving electric characteristics determined from the

characteristics of a polymer layer formed as dielectric substance by

a vapor deposition polymerization method

Constitution: A thin film capacitor 1 is provided with a substrate 2 on which multilayered structure 5 constituted of film type inner electrodes 3a, 3b, 3c and film type dielectric substance 4a, 4b is formed. The dielectric substance 4a, 4b is composed of a polymer

film of phloroalkylated aromatic polyimide containing Nmethylacridimium-7,7,8,8-tetracyanoquino dimethane complex (which is called 'TCNQ complex' hereafter). The polymer film of pholoroalkylated aromatic polyimide containing the TCNQ complex is formed by a vapor deposition polymerization method applying the following to evaporation source material; monomer of 2-2 bis (4aminophenyl) hexaphloropropane, monomer of pyromellitic

dihydride and crystal of TCNQ complex. COPYRIGHT: (C)1994, JPO& Japio

Other Abstract Info:

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(54) THIN FILM CAPACITOR

(57) Abstract:

PURPOSE: To obtain a thin film capacitor capable of further improving electric characteristics determined from the characteristics of a polymer layer formed as dielectric substance by a vapor deposition polymerization method.

CONSTITUTION: A thin film capacitor 1 is provided with a substrate 2 on which multilayered structure 5 constituted of film type inner electrodes 3a, 3b, 3c and film type dielectric substance 4a, 4b is formed. The dielectric substance 4a, 4b is composed of a polymer film of phloroalkylated aromatic polyimide containing N-methylacridimium-7,7,8,8-tetracyanoquino dimethane complex (which is called 'TCNO complex' hereafter). The polymer film of pholoroalkylated aromatic polyimide containing the TCNO complex is formed by a vapor deposition polymerization method applying the following to evaporation source material; monomer of 2-2 bis (4-aminophenyl) hexaphloropropane,

